

Form PTO-149		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 30-5016(4015)		SERIAL NO. 09/488,973			
<div style="border: 2px solid black; border-radius: 50%; padding: 10px; display: inline-block; transform: rotate(-45deg); transform-origin: center;"> OIPE JCSA MAR 31 2003 PATENT & TRADEMARK OFFICE </div>				LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Christopher L. Parfeniuk et al.	
				FILING DATE January 20, 2000		GROUP 2823			

U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	US 2002/0174917 A1	Pub. 11/28/02	Segal et al.			
	AB						
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	AD						
	AE						
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FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
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				FILING DATE January 20, 2000		GROUP 2823	

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U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA	4,842,706	06/89	Fukasawa et al.				
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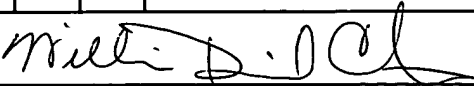
FOREIGN PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
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AM	6-65733	03/94	JP			X	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
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EXAMINER <i>Miller D. Paul</i>	DATE CONSIDERED <i>6/20/03</i>
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*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	US 2002/0003010 A1	Pub 01/10/02	Shah et al.			
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Christopher L. Parfeniuk et al.FILING DATE
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		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
AM		0 881 311 A1	12/98	EPO				
AN		US 01/07404	03/01	PCT Search Report				
AQ								
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